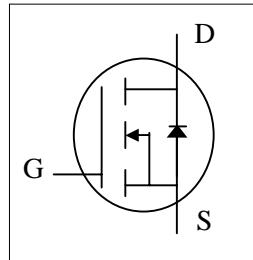




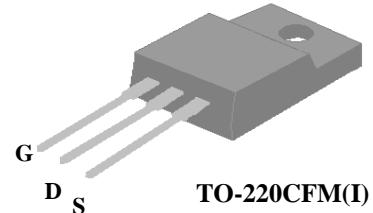
- ▼ Simple Drive Requirement
- ▼ Isolation Full Package
- ▼ Fast Switching Characteristics
- ▼ RoHS Compliant & Halogen-Free



BV_{DSS}	900V
$R_{DS(ON)}$	7.2Ω
I_D	1.9A

Description

The TO-220CFM package is universally preferred for all commercial-industrial applications. The device is suited for switch mode power supplies, AC-DC converters and high current high speed switching circuits.



Absolute Maximum Ratings

Symbol	Parameter	Rating	Units
V_{DS}	Drain-Source Voltage	900	V
V_{GS}	Gate-Source Voltage	± 30	V
$I_D @ T_C = 25^\circ\text{C}$	Continuous Drain Current, $V_{GS} @ 10\text{V}$	1.9	A
$I_D @ T_C = 100^\circ\text{C}$	Continuous Drain Current, $V_{GS} @ 10\text{V}$	1.2	A
I_{DM}	Pulsed Drain Current ¹	6	A
$P_D @ T_C = 25^\circ\text{C}$	Total Power Dissipation	34.7	W
	Linear Derating Factor	0.28	W/ $^\circ\text{C}$
E_{AS}	Single Pulse Avalanche Energy ²	18	mJ
I_{AR}	Avalanche Current	1.9	A
T_{STG}	Storage Temperature Range	-55 to 150	$^\circ\text{C}$
T_J	Operating Junction Temperature Range	-55 to 150	$^\circ\text{C}$

Thermal Data

Symbol	Parameter	Value	Units
R_{thj-c}	Maximum Thermal Resistance, Junction-case	3.6	$^\circ\text{C}/\text{W}$
R_{thj-a}	Maximum Thermal Resistance, Junction-ambient	62	$^\circ\text{C}/\text{W}$



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Electrical Characteristics @ $T_j=25^\circ\text{C}$ (unless otherwise specified)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{\text{GS}}=0\text{V}$, $I_D=1\text{mA}$	900	-	-	V
$\Delta \text{BV}_{\text{DSS}}/\Delta T_j$	Breakdown Voltage Temperature Coefficient	Reference to 25°C , $I_D=1\text{mA}$	-	0.8	-	$\text{V}/^\circ\text{C}$
$R_{\text{DS}(\text{ON})}$	Static Drain-Source On-Resistance	$V_{\text{GS}}=10\text{V}$, $I_D=0.85\text{A}$	-	-	7.2	Ω
$V_{\text{GS}(\text{th})}$	Gate Threshold Voltage	$V_{\text{DS}}=V_{\text{GS}}$, $I_D=250\text{\mu A}$	2	-	4	V
g_f	Forward Transconductance	$V_{\text{DS}}=10\text{V}$, $I_D=1.9\text{A}$	-	2	-	S
I_{DSS}	Drain-Source Leakage Current	$V_{\text{DS}}=900\text{V}$, $V_{\text{GS}}=0\text{V}$	-	-	10	\mu A
	Drain-Source Leakage Current ($T_j=125^\circ\text{C}$)	$V_{\text{DS}}=720\text{V}$, $V_{\text{GS}}=0\text{V}$	-	-	100	\mu A
I_{GSS}	Gate-Source Leakage	$V_{\text{GS}}=\pm 30\text{V}$, $V_{\text{DS}}=0\text{V}$	-	-	± 100	nA
Q_g	Total Gate Charge ³	$I_D=1.9\text{A}$	-	12	20	nC
Q_{gs}	Gate-Source Charge	$V_{\text{DS}}=540\text{V}$	-	2.5	-	nC
Q_{gd}	Gate-Drain ("Miller") Charge	$V_{\text{GS}}=10\text{V}$	-	4.7	-	nC
$t_{\text{d}(\text{on})}$	Turn-on Delay Time ³	$V_{\text{DD}}=450\text{V}$	-	10	-	ns
t_r	Rise Time	$I_D=1.9\text{A}$	-	5	-	ns
$t_{\text{d}(\text{off})}$	Turn-off Delay Time	$R_G=10\Omega$	-	18	-	ns
t_f	Fall Time	$V_{\text{GS}}=10\text{V}$	-	9	-	ns
C_{iss}	Input Capacitance	$V_{\text{GS}}=0\text{V}$	-	630	1000	pF
C_{oss}	Output Capacitance	$V_{\text{DS}}=25\text{V}$	-	40	-	pF
C_{rss}	Reverse Transfer Capacitance	f=1.0MHz	-	4	-	pF

Source-Drain Diode

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
V_{SD}	Forward On Voltage ³	$I_S=1.9\text{A}$, $V_{\text{GS}}=0\text{V}$	-	-	1.3	V
t_{rr}	Reverse Recovery Time	$I_S=1.9\text{A}$, $V_{\text{GS}}=0\text{V}$,	-	360	-	ns
Q_{rr}	Reverse Recovery Charge	$dI/dt=100\text{A}/\mu\text{s}$	-	1.8	-	μC

Notes:

1. Pulse width limited by maximum junction temperature.
2. Starting $T_j=25^\circ\text{C}$, $V_{\text{DD}}=50\text{V}$, $L=10\text{mH}$, $R_G=25\Omega$, $I_{\text{AS}}=1.9\text{A}$.
3. Pulse width $\leq 300\text{us}$, duty cycle $\leq 2\%$.

THIS PRODUCT IS SENSITIVE TO ELECTROSTATIC DISCHARGE, PLEASE HANDLE WITH CAUTION.

USE OF THIS PRODUCT AS A CRITICAL COMPONENT IN LIFE SUPPORT OR OTHER SIMILAR SYSTEMS IS NOT AUTHORIZED.

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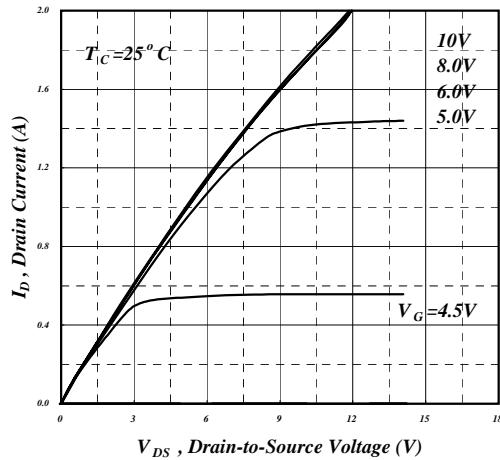


Fig 1. Typical Output Characteristics

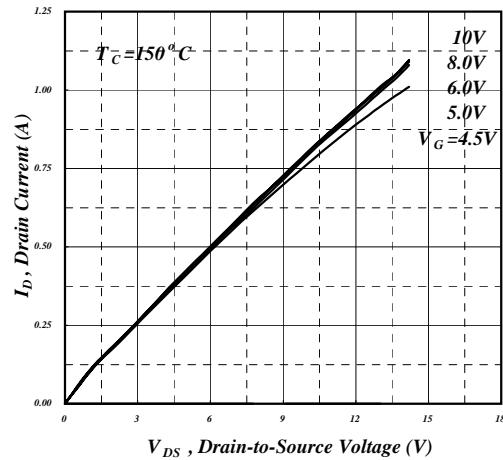


Fig 2. Typical Output Characteristics

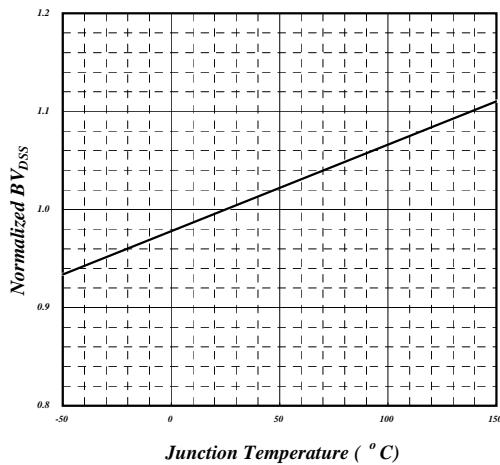
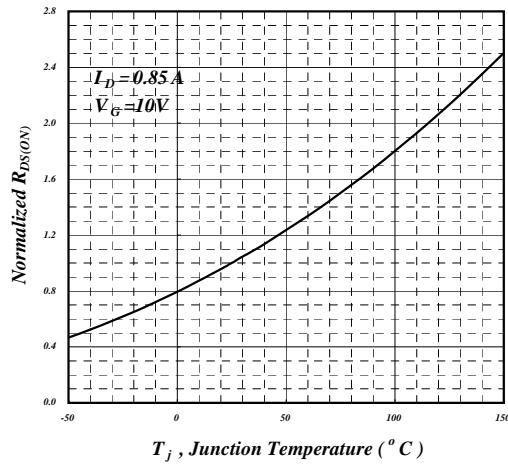
Fig 3. Normalized BV_{DSSS} v.s. Junction Temperature

Fig 4. Normalized On-Resistance v.s. Junction Temperature

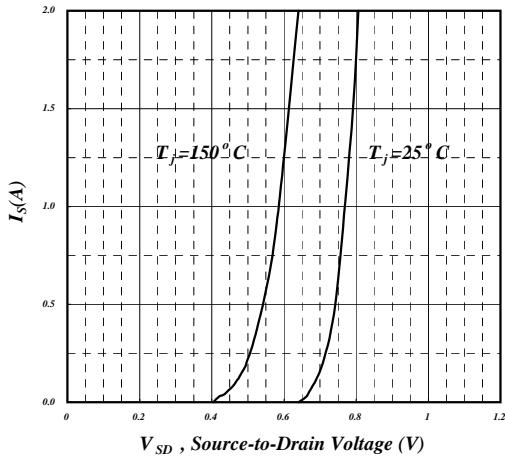


Fig 5. Forward Characteristic of Reverse Diode

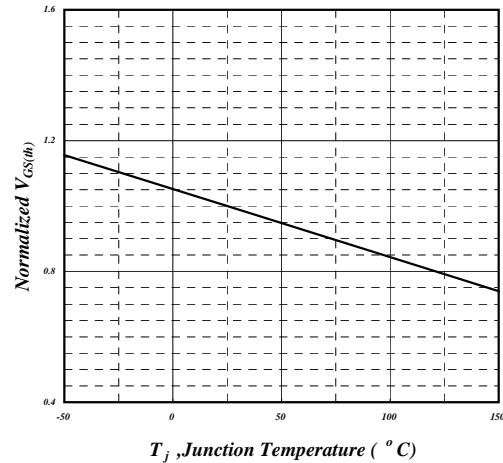


Fig 6. Gate Threshold Voltage v.s. Junction Temperature

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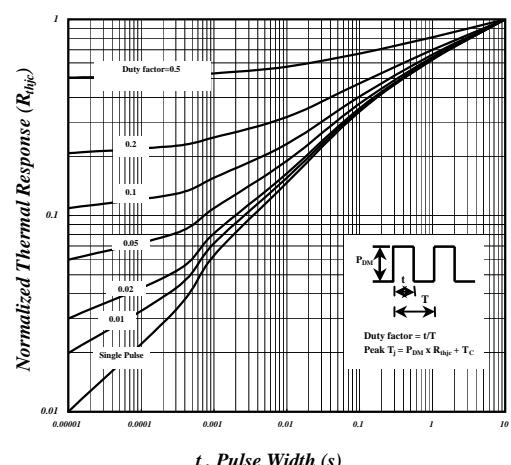
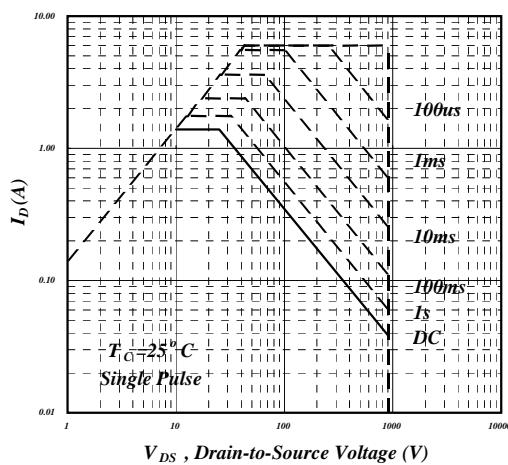
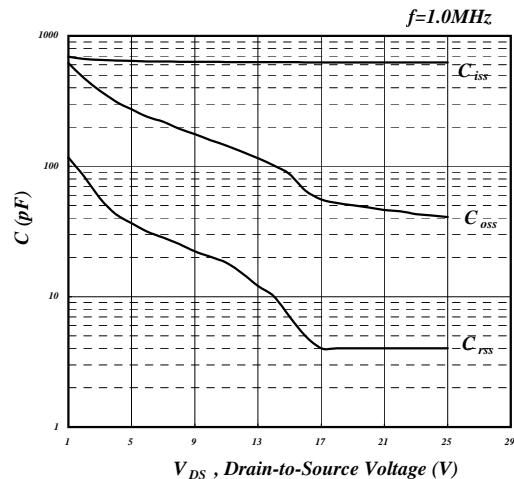
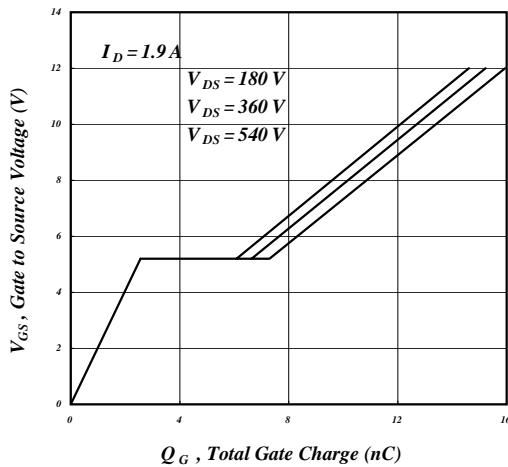


Fig 11. Switching Time Waveform

